

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**Circuit boards and circuit board assemblies – Design and use –  
Part 6-2: Land pattern design – Description of land pattern for the most common  
surface mounted components (SMD)**

**Cartes imprimées et cartes imprimées équipées – Conception et utilisation –  
Partie 6-2: Conception de la zone de report – Description de la zone de report  
pour les composants montés en surface (CMS) les plus courants**



## THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2021 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de l'IEC ou du Comité national de l'IEC du pays du demandeur. Si vous avez des questions sur le copyright de l'IEC ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de l'IEC de votre pays de résidence.

IEC Central Office  
3, rue de Varembe  
CH-1211 Geneva 20  
Switzerland

Tel.: +41 22 919 02 11  
[info@iec.ch](mailto:info@iec.ch)  
[www.iec.ch](http://www.iec.ch)

### About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

### About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigendum or an amendment might have been published.

#### IEC publications search - [webstore.iec.ch/advsearchform](http://webstore.iec.ch/advsearchform)

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee, ...). It also gives information on projects, replaced and withdrawn publications.

#### IEC online collection - [oc.iec.ch](http://oc.iec.ch)

Discover our powerful search engine and read freely all the publications previews. With a subscription you will always have access to up to date content tailored to your needs.

#### IEC Just Published - [webstore.iec.ch/justpublished](http://webstore.iec.ch/justpublished)

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and once a month by email.

#### Electropedia - [www.electropedia.org](http://www.electropedia.org)

The world's leading online dictionary on electrotechnology, containing more than 22 000 terminological entries in English and French, with equivalent terms in 18 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online

#### IEC Customer Service Centre - [webstore.iec.ch/csc](http://webstore.iec.ch/csc)

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: [sales@iec.ch](mailto:sales@iec.ch).

### A propos de l'IEC

La Commission Electrotechnique Internationale (IEC) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

### A propos des publications IEC

Le contenu technique des publications IEC est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

#### Recherche de publications IEC -

[webstore.iec.ch/advsearchform](http://webstore.iec.ch/advsearchform)

La recherche avancée permet de trouver des publications IEC en utilisant différents critères (numéro de référence, texte, comité d'études, ...). Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

#### IEC online collection - [oc.iec.ch](http://oc.iec.ch)

Découvrez notre puissant moteur de recherche et consultez gratuitement tous les aperçus des publications. Avec un abonnement, vous aurez toujours accès à un contenu à jour adapté à vos besoins.

#### IEC Just Published - [webstore.iec.ch/justpublished](http://webstore.iec.ch/justpublished)

Restez informé sur les nouvelles publications IEC. Just Published détaille les nouvelles publications parues. Disponible en ligne et une fois par mois par email.

#### Electropedia - [www.electropedia.org](http://www.electropedia.org)

Le premier dictionnaire d'électrotechnologie en ligne au monde, avec plus de 22 000 articles terminologiques en anglais et en français, ainsi que les termes équivalents dans 16 langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (IEV) en ligne.

#### Service Clients - [webstore.iec.ch/csc](http://webstore.iec.ch/csc)

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: [sales@iec.ch](mailto:sales@iec.ch).

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**Circuit boards and circuit board assemblies – Design and use –  
Part 6-2: Land pattern design – Description of land pattern for the most common  
surface mounted components (SMD)**

**Cartes imprimées et cartes imprimées équipées – Conception et utilisation –  
Partie 6-2: Conception de la zone de report – Description de la zone de report  
pour les composants montés en surface (CMS) les plus courants**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

COMMISSION  
ELECTROTECHNIQUE  
INTERNATIONALE

ICS 31.180; 31.190

ISBN 978-2-8322-9354-6

**Warning! Make sure that you obtained this publication from an authorized distributor.  
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

## CONTENTS

FOREWORD.....	4
1 Scope.....	6
2 Normative references .....	6
3 Terms and definitions .....	6
4 Kinds of target solder process .....	6
5 Land pattern determination.....	6
6 Requirements .....	7
6.1 General requirements .....	7
6.2 The proposed land pattern dimension system .....	7
6.2.1 Land pattern design.....	7
6.2.2 Solder joint fillet design .....	8
6.2.3 Courtyard excess.....	10
6.2.4 Rounding factor .....	10
6.2.5 Relationship between terminal classifications and class of land pattern .....	10
6.2.6 Terminal types.....	10
6.3 Land pattern for wave soldering .....	14
6.3.1 General .....	14
6.3.2 Flat bottom terminals.....	14
6.3.3 Flat bottom and vertical side terminals.....	14
6.4 Land pattern for reflow soldering.....	15
6.4.1 General .....	15
6.4.2 Flat bottom terminals .....	15
6.4.3 Flat bottom and vertical side terminals.....	15
6.4.4 Remarks.....	16
Annex A (informative) The relation between terminal type and component packages .....	19
A.1 Flat bottom terminals .....	19
A.2 Flat bottom and vertical side terminals .....	19
Annex B (informative) Solder joint fillet designs for wave soldering.....	22
Annex C (informative) Courtyard excess for reflow soldering .....	23
C.1 Courtyard excess for flat bottom terminals to use the land pattern for reflow soldering.....	23
C.2 Courtyard excess for flat bottom and vertical side terminals to use the land pattern for reflow soldering .....	23
Bibliography.....	25
Figure 1 – Example of the dimensional relationship between the drawings of components with rectangular terminals and the land pattern design.....	9
Figure 2 – Definitions of dimensions of the flat bottom terminal types .....	11
Figure 3 – Definitions of dimensions of the flat bottom and vertical side terminal types.....	14
Figure 4 – Solder touches image.....	17
Figure 5 – Unacceptable conditions for overhangs .....	18
Table 1 – Relationship between terminal classifications and class of land pattern.....	10
Table 2 – Conformity to the wave soldering of the terminal types .....	14

Table 3 – Land pattern dimensions for Flat bottom terminals soldered by reflow soldering.....	15
Table 4 – Land pattern dimensions for flat bottom and vertical side terminals soldered by reflow soldering.....	16
Table A.1 – Terminal type classifications 1 – Flat bottom terminals.....	19
Table A.2 – Terminal type classifications 2 – Flat bottom and vertical side terminals .....	20
Table B.1 – Solder joint fillet design for wave soldering .....	22
Table C.1 – Courtyard excess for flat bottom terminals to use the land pattern for reflow soldering .....	23
Table C.2 – Courtyard excess for flat bottom and vertical side terminals to use the land pattern for reflow soldering.....	24

## **iTeh STANDARD PREVIEW** **(standards.iteh.ai)**

[IEC 61188-6-2:2021](https://standards.iteh.ai/catalog/standards/sist/119ba72d-d63a-40d0-bf59-d7df69f0c7c9/iec-61188-6-2-2021)

<https://standards.iteh.ai/catalog/standards/sist/119ba72d-d63a-40d0-bf59-d7df69f0c7c9/iec-61188-6-2-2021>

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**CIRCUIT BOARDS AND CIRCUIT BOARD ASSEMBLIES –  
DESIGN AND USE –**

**Part 6-2: Land pattern design – Description of land pattern  
for the most common surface mounted components (SMD)**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

IEC 61188-6-2 has been prepared by IEC technical committee 91: Electronics assembly technology. It is an International Standard.

The text of this International Standard is based on the following documents:

Draft	Report on voting
91/1637/CDV	91/1657/RVC

Full information on the voting for its approval can be found in the report on voting indicated in the above table.

The language used for the development of this International Standard is English.

This document was drafted in accordance with ISO/IEC Directives, Part 2, and developed in accordance with ISO/IEC Directives, Part 1 and ISO/IEC Directives, IEC Supplement, available at [www.iec.ch/members\\_experts/refdocs](http://www.iec.ch/members_experts/refdocs). The main document types developed by IEC are described in greater detail at [www.iec.ch/standardsdev/publications](http://www.iec.ch/standardsdev/publications).

A list of all parts in the IEC 61188 series, published under the general title *Circuit boards and circuit board assemblies – Design and use*, can be found on the IEC website.

Future documents in this series will carry the new general title as cited above. Titles of existing documents in this series will be updated at the time of the next edition.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under [webstore.iec.ch](http://webstore.iec.ch) in the data related to the specific document. At this date, the document will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

**IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.**

ITEH STANDARD PREVIEW

(standards.iteh.ai)

[IEC 61188-6-2:2021](https://standards.iteh.ai/catalog/standards/sist/119ba72d-d63a-40d0-bf59-d7df69f0c7c9/iec-61188-6-2-2021)

<https://standards.iteh.ai/catalog/standards/sist/119ba72d-d63a-40d0-bf59-d7df69f0c7c9/iec-61188-6-2-2021>

## CIRCUIT BOARDS AND CIRCUIT BOARD ASSEMBLIES – DESIGN AND USE –

### Part 6-2: Land pattern design – Description of land pattern for the most common surface mounted components (SMD)

#### 1 Scope

This part of IEC 61188 describes the requirements of design and use for soldering surfaces of land pattern on circuit boards. This document includes land pattern for surface mounted components. These requirements are based on the solder joint requirements of IEC 61191-2:2017.

#### 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60194-2, *Printed boards design, manufacture and assembly – Vocabulary – Part 2: Common usage in electronic technologies as well as printed board and electronic assembly technologies*

IEC 61188-6-1, *Circuit boards and circuit board assemblies – Design and use – Part 6-1: Land pattern design – Generic requirements for land pattern on circuit boards*

IEC 61188-6-4, *Printed boards and printed board assemblies – Design and use – Part 6-4: Land pattern design – Generic requirements for dimensional drawings of surface mounted components (SMD) from the viewpoint of land pattern design*

IEC 61191-2:2017, *Printed board assemblies – Part 2: Sectional specification – Requirements for surface mount soldered assemblies*

#### 3 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 60194-2 and IEC 61188-6-1 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

#### 4 Kinds of target solder process

Typical soldering methods used in surface mount technology include, but are not limited to:

- a) reflow soldering for all process types;
- b) wave soldering of surface mounted component.

#### 5 Land pattern determination

This standard discusses the following method of providing information on land patterns.

For each typical termination type, one land pattern for one termination will be determined by formulas based on the termination dimensions (nominal value).



The assumption is that the following dimensions have the necessary and sufficient accuracy:

- a) component tolerance;
- c) printed board fabrication tolerance;
- d) placement tolerance.

NOTE Further information on the effect of the above dimensional tolerance on the land pattern can be found in Annex A of IEC 61188-6-1:2021.

There are two classes of land pattern relating to the assembly limitations of components and the intended soldering process:

- land pattern for wave soldering – For low density product applications, land patterns are designed to accommodate several types of wave soldering applicable to surface mounted components.
- land pattern for reflow soldering – The land patterns generated for all device families shall provide a robust solder attachment condition for reflow soldering.

## 6 Requirements

### 6.1 General requirements

The calculated land pattern geometry for an electronic component can be different depending upon the type of soldering process to be used. Wherever possible, land patterns should be defined in such a manner that are transparent to the attachment process being used. Land pattern designers can use the information contained herein to establish standard configurations not only for manual designs but also for computer-aided design systems.

Whether parts are mounted on one side or both sides of the board, subjected to wave soldering, reflow soldering, or other type of soldering, the land pattern and part dimensions should be optimized to insure proper solder joint and inspection criteria.

Although patterns are dimensionally defined and since they are a part of the circuit board geometry, they are subject to the reducibility levels and tolerances associated with plating, etching, assembly or other conditioning process. The producibility aspects also pertain to the use of solder mask and the registration required between the solder mask and the conductor patterns.

A correctly designed land pattern is essential to satisfy quality standards such as IEC 61191-2:2017, which specifies generic requirements for the concept of land pattern design. The land pattern designer should design in accordance with the concept in this document, and they could adopt appropriate numeric values that were suitable for their purpose. The numeric values described in this document are the parameters that were selected as references to show the concept of land-pattern design.

### 6.2 The proposed land pattern dimension system

#### 6.2.1 Land pattern design

Distance between lands measured from outside edges ( $Z$ ) and distance between lands measured from inside edges ( $G$ ) are given by the following Formula (1) and Formula (2).

NOTE In Figure 1 e), the area surrounded by dashed lines is the courtyard.

Figure 1 shows a typical example of the relationship between the land pattern design and the component dimensions. The requirements contained in IEC 61188-6-4 about the relationship between dimensions shall apply.

$$Z = H_E + 2 \times J_T \quad (1)$$

$$G = S - 2 \times J_H \quad (2)$$

where:

$Z$  is the distance between lands, expressed in mm. Measured from outside edges;

$G$  is the distance between lands, expressed in mm. Measured from inside edges;

$H_E$  is the SMD total length (nominal), expressed in mm;

$S$  is the distance between the solder terminals measured from inside edges, expressed in mm;

$J_T$  is the toe protrusion length, expressed in mm;

$J_H$  is the heel protrusion length, expressed in mm.

### 6.2.2 Solder joint fillet design

Land width ( $X$ ) and land length ( $Y$ ) are given by the following Formula (3) and Formula (4).

$$X = W_1 + 2 \times J_S \quad (3)$$

$$Y = J_T + L_P + J_H \quad (4)$$

where

$X$  is the land width (nominal), expressed in mm;

$Y$  is the land length (nominal), expressed in mm;

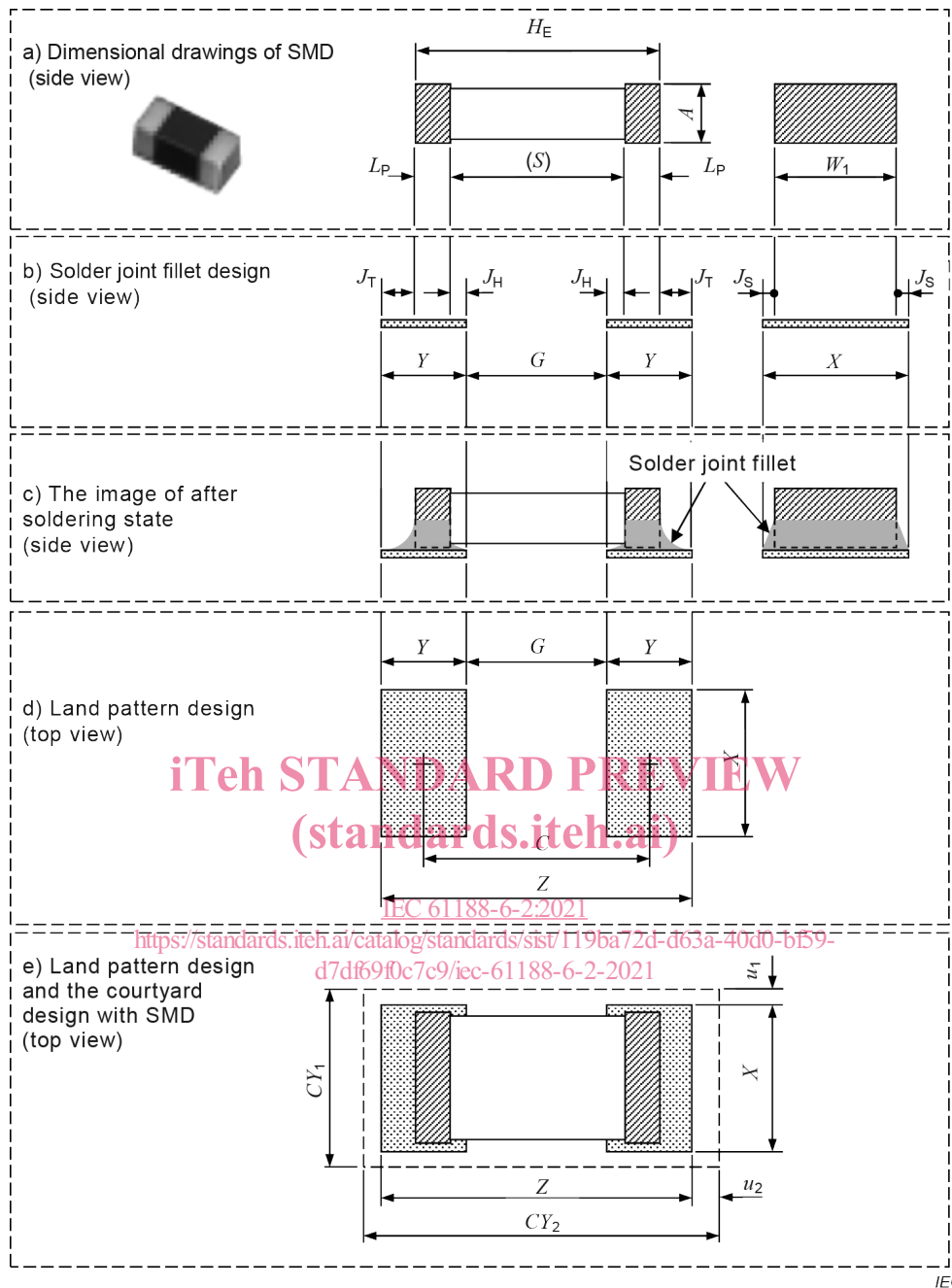
$W_1$  is the terminal width (nominal), expressed in mm;

$L_P$  is the solder terminal length (nominal), expressed in mm;

$J_T$  is the toe protrusion length, expressed in mm;

$J_H$  is the heel protrusion length, expressed in mm;

$J_S$  is the side protrusion length, expressed in mm.

**Key**

$H_E$	SMD total length (nominal)	$X$	Land width
$W_1$	Terminal width (nominal)	$Y$	Land length
$A$	SMD height (from the mounting surface to the package upper surface) (nominal)	$G$	Distance between lands. Measured from inside edges
$L_P$	Solder terminal length (mounting surface side) (nominal)	$C$	Row spacing. Distance between land centers
$S$	Distance between the solder terminals. Measured from inside edges	$Z$	Distance between lands. Measured from outside edges
$J_T$	Toe protrusion length	$CY_1$	Courtyard width
$J_H$	Heel protrusion length	$CY_2$	Courtyard length
$J_S$	Side protrusion length	$u_1, u_2$	Allowance for courtyard

NOTE In Figure 1 e), the area surrounded by dashed lines is the courtyard.

**Figure 1 – Example of the dimensional relationship between the drawings of components with rectangular terminals and the land pattern design**

**6.2.3 Courtyard excess**

Since courtyard excess is influenced by equipment performance, part size accuracy, provision for rework, etc., it should be desirable for the user to decide it. Therefore, in this document, courtyard excess is indicated as a reference value in Annex C.

**6.2.4 Rounding factor**

The rounding factor of the land pattern dimension should be 0,01 mm in general. However, if the rounding factor exceeds 10 % of the dimension, the rounding factor can be decreased to 0,005 mm.

**6.2.5 Relationship between terminal classifications and class of land pattern**

Relationship between terminal classifications and class of land pattern are given in Table 1.

For the relationship between each terminal type contained in the terminal classifications and component classifications, see Annex A.

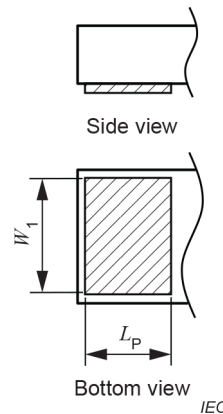
**Table 1 – Relationship between terminal classifications and class of land pattern**

Terminal classification	Class of land pattern	
	For wave soldering	For reflow soldering
Flat bottom terminals	<b>6.3.2</b> (The basic design rule is not defined)	<b>6.4.1</b> The basic design rule is shown in Table 3
Flat bottom and vertical side terminals	<b>6.3.3</b> Available termination types are shown in Table 2 (The basic design rule is not defined)	<b>6.4.2</b> The basic design rule is shown in Table 4

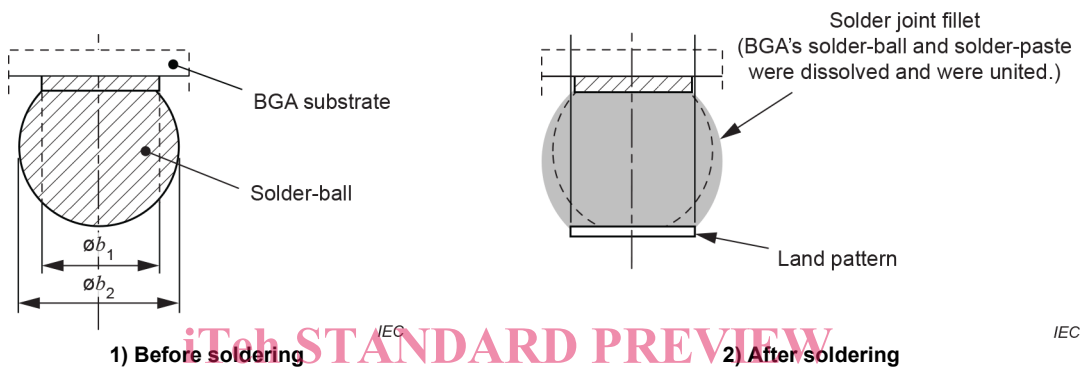
iTeH STANDARD PREVIEW  
(standards.iteh.ai)  
<https://standards.iteh.ai/catalog/standards/sis/119ba72d-d63a-40d0-bf59-d7df69f0c7c9/iec-61188-6-2-2021>

**6.2.6 Terminal types**

Figure 2 shows the flat bottom terminal types, and Figure 3 shows the Flat bottom and vertical side terminal types with dimension symbols used in this document.



a) **Bottom only chip terminal**

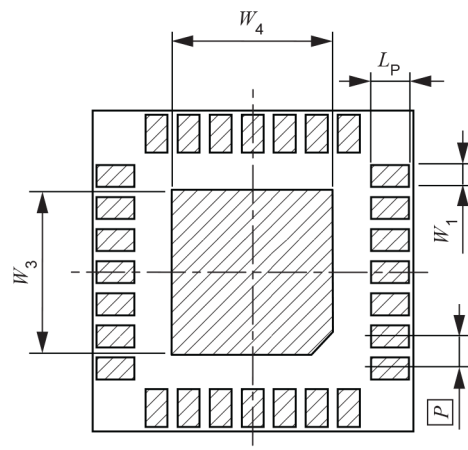


1) Before soldering 2) After soldering

b) **BGA terminal**

(standards.iteh.ai)

IEC 61188-6-2:2021 Without wettable flanks  
<https://standards.iteh.ai/catalog/standards/sis/119ba72d-d63a-40d0-bf59-d7df690c7c9/iec-61188-6-2-2021>

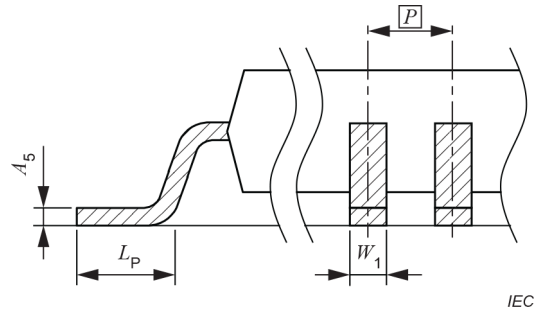


c) **BTC (QFN) terminal**

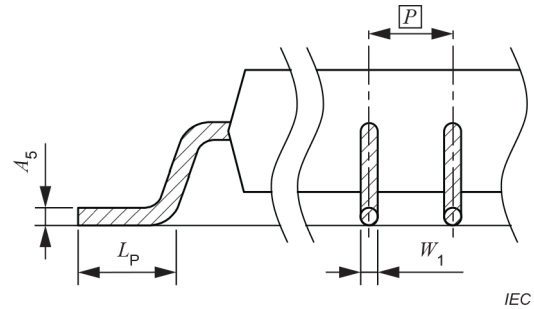
**Key**

- $\varnothing b_1$  Terminal diameter for ball
- $\varnothing b_2$  Ball diameter
- $L_P$  Solder terminal length (mounting surface side)
- $P$  Pitch
- $W_1$  Terminal width
- $W_3$  Bottom centre (GND) terminal length
- $W_4$  Bottom centre (GND) terminal width

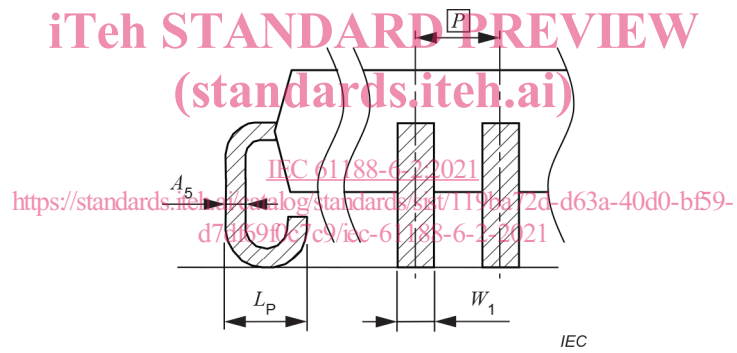
**Figure 2 – Definitions of dimensions of the flat bottom terminal types**



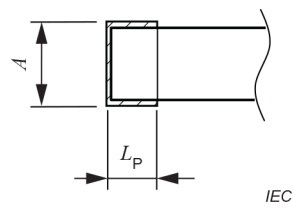
a) Flat ribbon L and gull-wing terminal



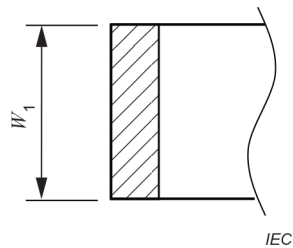
b) Round or flattened (coined) terminal



c) J terminal

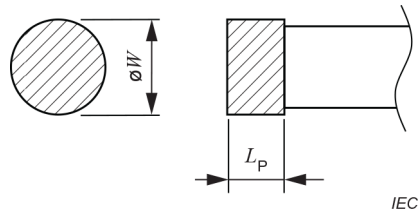


Side view

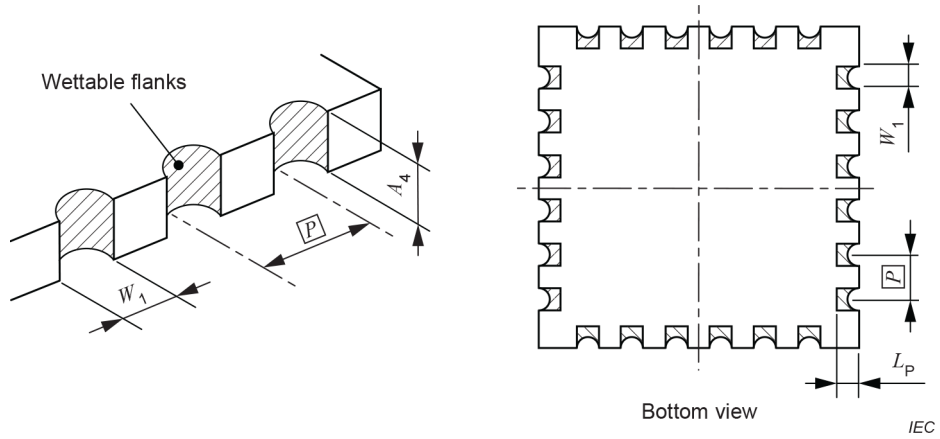


Bottom view

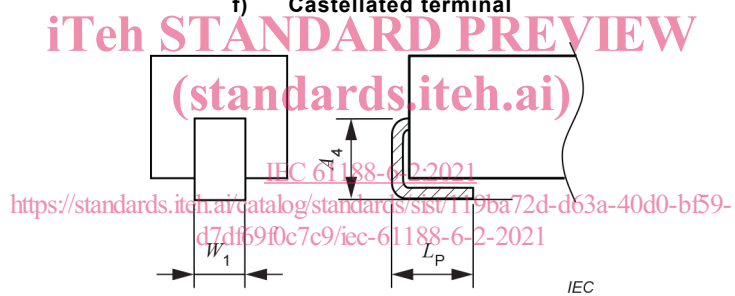
d) Rectangular or square end terminal



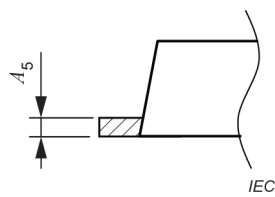
e) Cylindrical End Cap terminal



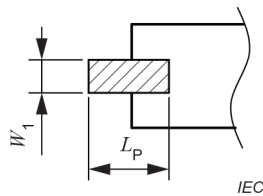
f) Castellated terminal



g) Inward L-shaped ribbon terminal



Side View



Bottom View

h) Flat lug terminal